

Notice of References Cited

Application/Control No.

10/597,037

Applicant(s)/Patent Under
Reexamination
MEIER ET AL.

Examiner

MARINA TIETJEN

Art Unit

3753

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,662,396 A	05-1987	Avnon, Mordechi	137/616.7
*	B	US-4,905,965 A	03-1990	Dolev, Moshe	251/149.9
*	C	US-5,050,841 A	09-1991	Jacobsson, Rolf A.	251/149.9
*	D	US-6,422,267 B1	07-2002	Makishima et al.	137/616.7
*	E	US-2004/0239111 A1	12-2004	Wuthrich, Hans	285/283
*	F	US-6,899,132 B2	05-2005	Mikiya et al.	137/616.7
*	G	US-D521,614 S	05-2006	Kitagawa, Hiroyuki	D23/262
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

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